

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/689,932	PARK ET AL.	
	Examiner	Art Unit	Page 1 of 1
	Junpeng Chen	2618	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,023,491 A	02-2000	Saka et al.	375/326
*	B	US-6,125,135 A	09-2000	Woo et al.	375/130
*	C	US-6,417,737 B1	07-2002	Moloudi et al.	330/301
*	D	US-2003/0012313 A1	01-2003	Husted et al.	375/345
*	E	US-6,560,449 B1	05-2003	Liu, Bin	455/302
*	F	US-6,987,794 B1	01-2006	Kohno et al.	375/136
*	G	US-7,092,675 B2	08-2006	Lim et al.	455/76
*	H	US-7,136,431 B2	11-2006	Shi et al.	375/319
*	I	US-7,228,109 B2	06-2007	Paulus et al.	455/74
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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